

<b>Notice of References Cited</b>	Application/Control No. 10/821,736	Applicant(s)/Patent Under Reexamination TAKEUCHI ET AL.	
	Examiner Mark J. Beauchaine	Art Unit 3653	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0084521	05-2004	Nagayoshi et al.	235/379
*	B	US-6,874,682	04-2005	Utz et al.	235/379
*	C	US-4,524,268	06-1985	Fukatsu, Kunio	235/379
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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